

Amendments to the Claims:

This listing of claims replaces all prior versions and listings of claims in the application:

Listing of Claims:

1. (Currently amended) A method for manufacturing circuit devices comprising:
 - preparing a laminated plate by laminating a first conductive film and a second conductive film via a third conductive film;
 - forming a conductive wiring layer by etching said first conductive film into a ~~desirable~~ pattern;
 - removing said third conductive film by use of said conductive wiring layer as a mask;
 - covering front-surface portions of the second conductive film exposed by removing said third conductive film, said conductive wiring layer, and end faces of the third conductive film with an insulating layer;
 - partially exposing said conductive wiring layer by removing a part of said insulating layer;
 - fixedly fitting semiconductor elements onto said insulating layer and electrically connecting said semiconductor elements with said conductive wiring layer;
 - covering said semiconductor elements with a sealing resin layer; and
 - removing said second conductive film to expose said third conductive film on the rear surface.
2. (Original) The method for manufacturing circuit devices as set forth in Claim 1, wherein
 - said conductive wiring layer is formed by performing etching up to said third conductive film.

3. (Currently amended) The method for manufacturing circuit devices as set forth in Claim 2, wherein said first conductive film is etched with a solution a solution to etch said first conductive film is used.

4. (Currently amended) The method for manufacturing circuit devices as set forth in Claim 2 or 3, wherein ~~as said solution for performing said etching~~, a solution containing ferric chloride or cupric chloride is used to etch the first conductive film.

5. (Original) The method for manufacturing circuit devices as set forth in Claim 1, wherein said third conductive film is removed by electrolytic peeling.

6. (Currently amended) The method for manufacturing circuit devices as set forth in Claim 1, wherein said third conductive film is removed ~~by etching by use of~~ by using a solution to etch said third conductive film.

7. (Original) The method for manufacturing circuit devices as set forth in Claim 6, wherein said solution is an iodine-based solution.

8. (Original) The method for manufacturing circuit devices as set forth in Claim 1, wherein said second conductive film is entirely etched.

9. (Currently amended) The method for manufacturing circuit devices as set forth in Claim 1, wherein said second conductive film is ~~formed~~ thicker than said first conductive film.

10. (Original) The method for manufacturing circuit devices as set forth in Claim 1, wherein said insulating layer can be a thermoplastic resin, a thermosetting resin, or a photosensitive resin.

11. (Original) The method for manufacturing circuit devices as set forth in Claim 1, wherein said first conductive film and said second conductive film are metals made of copper as a main material, and said third conductive film is a metal made of silver as a main material.

12. (Original) The method for manufacturing circuit devices as set forth in Claim 1, wherein said laminated plate is manufactured by laminating said third conductive film and said first conductive film by electroplating while using said second conductive film as a base.

13. (Original) The method for manufacturing circuit devices as set forth in Claim 1, wherein said laminated plate is formed by rolling.

14. (Currently amended) The method for manufacturing circuit devices as set forth in Claim 1, wherein said parts of the exposed and plated first conductive film are electrically connected to parts and electronic components, ~~excluding semiconductor elements, are electrically connected.~~

15. (Original) The method for manufacturing circuit devices as set forth in Claim 1, wherein said insulating layer is formed by vacuum press or vacuum lamination.

16. (Original) The method for manufacturing circuit devices as set forth in Claim 1, wherein said insulating layer is partially removed by laser processing.

17. (Original) The method for manufacturing circuit devices as set forth in Claim 1, wherein said insulating layer is partially removed by a lithographic method.

18. (Currently amended) The method for manufacturing circuit devices as set forth in Claim 1, wherein ~~by electrolytic plating using said second conductive layer as an electrode, a~~

Applicant : Yusuke Igarashi et al.
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plated layer is formed on the exposed parts of said conductive wiring layer by electrolytic plating
in which the second conductive layer is used as an electrode.